

<b>Search Notes</b>  	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	09875076	LIAW ET AL.
	<b>Examiner</b> Lockard, Jon M	<b>Art Unit</b> 1647

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
NONE		8/29/07	JML

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
STIC Search of SEQ ID NOS:19-20. See sequence search results in SCORE.	7/3/07	JML
EAST SEARCH (USPAT, US-PGPUB, EPO, DERWENT): See attached search history	8/29/07	JML
STN (MEDLINE, SCISEARCH, EMBASE, BIOSIS). See attached search history.	8/29/07	JML
PALM: Inventor Search.	8/29/07	JML

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>